

COUNCIL FOR THE INDIAN SCHOOL CERTIFICATE EXAMINATIONS, NEW DELHI
INDIAN CERTIFICATE OF SECONDARY EDUCATION (CLASS - X) - YEAR 2019

No. TF 30109015



1196078/166

STATEMENT OF MARKS

Name **PRANAV AGARWAL**
of **ST. PETER'S COLLEGE, AGRA**
Unique ID **6848956**
Son of
Smt **NOOPUR AGARWAL**
Shri **MANISH AGARWAL**

SUBJECTS	TOTAL MARKS Max. Marks:100	PERCENTAGE MARKS
ENGLISH ENGLISH LANGUAGE LITERATURE IN ENGLISH	078 092	85 EIGHT FIVE
HINDI	091	91 NINE ONE
HISTORY, CIVICS & GEOGRAPHY HISTORY & CIVICS GEOGRAPHY	083 083	83 EIGHT THREE
MATHEMATICS	075	75 SEVEN FIVE
SCIENCE PHYSICS CHEMISTRY BIOLOGY	068 079 073	73 SEVEN THREE
COMPUTER APPLICATIONS	095	95 NINE FIVE
Internal Assessment SUPW AND COMMUNITY SERVICE		GRADE B

Date of birth as certified by the (in words) **Third January Two Thousand Three**
Head of the School at the time of (in figures) registration **03.01.2003**

RESULT - PASS CERTIFICATE AWARDED

Date of declaration of Result - **07.05.2019**

Note: 1. The pass mark for each subject is 33%
2. No divisions are awarded.

Chief Executive & Secretary

No. TF 90107571



1196078/166

107610

PASS CERTIFICATE

No divisions are awarded

This is to certify that **PRANAV AGARWAL**
of **ST. PETER'S COLLEGE, AGRA**

Unique ID **6848956**

Son of

Smt NOOPUR AGARWAL

Shri MANISH AGARWAL

was awarded an

INDIAN CERTIFICATE OF SECONDARY EDUCATION (CLASS-X)

The candidate attained at least grade **7** in **SIX** subjects of the External Examination and at least grade **D** in the subject of Internal Assessment as given below :

SUBJECTS	GRADE
External Examination	
ENGLISH	2 TWO
HINDI	1 ONE
HISTORY, CIVICS & GEOGRAPHY	2 TWO
MATHEMATICS	3 THREE
SCIENCE	3 THREE
COMPUTER APPLICATIONS	1 ONE

Internal Assessment

SUPW & COMMUNITY SERVICE

B

Date of birth as certified by the (in words) Third January Two Thousand Three Head of the School at the time of (in figures) 03.01.2003 registration

EXAMINATION YEAR 2019

Date of declaration of Result - 07.05.2019

Chief Executive & Secretary

Chairman
Council for the Indian School
Certificate Examinations

(See Overleaf)